Introduction **Design and software features** Phosphor screen is a P43 luminophore molten with KaptonTM. CCD camera Low-intensity experiments such as irradiation of materials and proton therapy are presented at INR RAS used for image registration is hidden behind heavy concrete wall. Basler linac and require diagnostics that can provide information acA780-75gm camera is used for image registration. Camera is displaced nonabout beam position, size and pulse. System of luminescent perpendicularly to luminescent screen plane and image is distorted. A LabVIEW program was written to make an image diagnostics is an appropriate one. Beam dump 2 Target correction. Stages of correction are presented in figure 2. This program Beam also provides information about image Beam pipe position, size and pulse charge on Gas counter with phosphor screen desktop frame (figure 3). Main program features are presented in table 1.

INR RAS linear accelerator is a high-intensity accelerator, mostly used for rare isotopes production and neutron experiments. However low-intensity beam research is also presented at INR linac and requires appropriate diagnostics, such as luminescent diagnostics, which is implemented at a new proton irradiation facility. Important experimental results of beam position, size and intensity measurements during accelerator run are discussed.

LUMINESCENT DIAGNOSTICS OF LOW INTENSITY PROTON BEAMS AT INR RAS LINAC

Abstract

A.I. Titov^{*}, S.A. Gavrilov, Institute of Nuclear Research RAS, Moscow Institute of Physics and Technology

aleksandr.titov@phystech.edu

THPSC39





Fig. 1. Layout of luminescent diagnostics components and phosphor screen at INR PIF.

Experimental results

During accelerator runs in system of luminescent diagnostics was used at the proton irradiation facility with beam energies from 20 to 209 MeV. It was used for beam



Fig. 2. Image correction procedure



	Program functions
のない	Background subtraction
	Synchronization switch
	(external or camera internal)
Contraction of the	Preliminary calibration of pulse
	charge with reference diagnostics
	Beam profiles with gaussian fitting
	Beam position calculation
	Beam size calculation
	Pulse charge calculation
	Pulse charge calculation in

control during irradiation of electronic components such as flash drives, microchips and hard drives (figure 4).



Fig. 3. Desktop frame.

T USE CHUIGE CUICUUIUN IN preferred region

Saving beam image and all parameters

Saving sequential 50 images

Changing camera gain and exposure without recalibration

 Table 1. Program functions.

Diagnostics limits

There are some limits which restrict luminescent diagnostics working range. If camera exposure is less than luminophore emission decay time light will not be collected by the camera entirely. Minimal exposure time is 8 ms (figure 6). A problem of camera pixel saturation exists, which leads to an increase in pulse charge measurement error. Figure 7 shows that error significantly grows from pulse charge of 16 nC/pulse.

Fig. 4. Beam images during irradiation of flash drives, hard drive and microchip.



Fig. 5. Beam images during accelerator run.



